

Search Notes

Application/Control No.

10/629,894

Examiner

TAN X. DINH

Applicant(s)/Patent under
Reexamination

YONEZAWA, MINORU

Art Unit

2627

SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST (see search history printout) | 3/13/2007 | T.D |
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INTERFERENCE SEARCHED

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| Interference Search History Printout | | 3/13/2007 | T.D |